

**Search Notes**

Application/Control No.

10/037,229

Examiner

Enrique L. Santiago

Applicant(s)/Patent under  
Reexamination

ARIKAWA ET AL.

Art Unit

2671

**SEARCHED**

Class	Subclass	Date	Examiner
345	419,427, 473	6/7/2005	ELS
345	619, 629	6/7/2005	ELS
345	630, 634	6/7/2005	ELS
715	757, 850	6/7/2005	ELS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same as above		6/7/2005	ELS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search (see attached)	6/7/2005	ELS